

AON3814

20V Dual N-Channel MOSFET

General Description

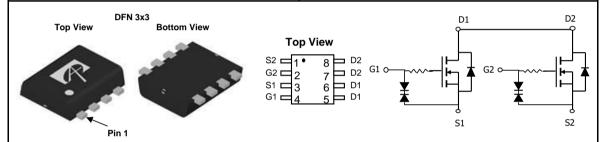
The AON3814 uses advanced trench technology to provide excellent $R_{\rm DS(ON)}$, low gate charge and operation with gate voltages as low as 1.8V while retaining a 12V $V_{\rm GS(MAX)}$ rating. It is ESD protected. This device is suitable for use as a uni-directional or bi-directional load switch, facilitated by its common-drain configuration.

Product Summary

 $\begin{array}{lll} V_{DS} & 20V \\ I_{D} \; (at \; V_{GS} \! = \! 4.5V) & 6A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 17 m \Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4V) & < 18.5 m \Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 3.1V) & < 23 m \Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 2.5V) & < 24 m \Omega \end{array}$

ESD Protected





Absolute Maximum Ratings T_A=25°C unless otherwise noted Parameter Symbol

Parameter		Symbol	Maximum	Units		
Drain-Source Voltage		V_{DS}	20	V		
Gate-Source Voltage		V_{GS}	±12	V		
Continuous Drain T	_C =25°C		6			
Current ^F T	_C =70°C	'D	5.3	А		
Pulsed Drain Current ^B		I _{DM}	40			
T	T _C =25°C		2.5	W		
Power Dissipation F T	_C =70°C	- D	1.6	VV		
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C		

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	40	50	°C/W			
Maximum Junction-to-Ambient A	Steady-State	$R_{\theta JA}$	75	95	°C/W			
Maximum Junction-to-Lead ^C	Steady-State	$R_{\theta JL}$	30	40	°C/W			



Electrical Characteristics (T_{.I}=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units			
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu A, V_{GS}=0V$	20			V			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =20V, V _{GS} =0V			1	μА			
	Zero Gate Voltage Drain Gurrent	T _J =55°C			5				
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±10V			10	μΑ			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_D=250\mu A$	0.3	0.7	1.1	V			
$I_{D(ON)}$	On state drain current	V_{GS} =4.5V, V_{DS} =5V	40			Α			
	Static Drain-Source On-Resistance	V _{GS} =4.5V, I _D =6A		12.5	17	mΩ			
		T _J =125°C		18.5	24	1112.2			
P		V_{GS} =4V, I_D =6A		12.9	18.5	mΩ			
R _{DS(ON)}		V_{GS} =3.1V, I_D =6A		14	23	mΩ			
		V_{GS} =2.5V, I_D =6A		15.6	24	mΩ			
		V_{GS} =1.8V, I_D =6A		23		mΩ			
9 _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =6A		33		S			
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.6	1	V			
Is	Maximum Body-Diode Continuous Current				3.5	Α			
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance		730	920	1100	pF			
Coss	Output Capacitance	V_{GS} =0V, V_{DS} =10V, f=1MHz	110	155	200	pF			
C_{rss}	Reverse Transfer Capacitance		45	75	105	pF			
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		2.4		kΩ			
SWITCHI	NG PARAMETERS			-	-				
Q_g	Total Gate Charge		8.8	11	13	nC			
Q_{gs}	Gate Source Charge	V_{GS} =4.5V, V_{DS} =10V, I_{D} =6A	1.6	2	2.4	nC			
Q_{gd}	Gate Drain Charge		1.9	3.2	4.5	nC			
t _{D(on)}	Turn-On DelayTime			0.3		μS			
t _r	Turn-On Rise Time	V_{GS} =5V, V_{DS} =10V, R_L =1.7 Ω ,		0.6		μS			
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}=3\Omega$		7.9		μS			
t _f	Turn-Off Fall Time			4.4		μS			

A. The value of R_{n1a} is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ$ C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using \leq 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T_{I(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initialT₁=25° C.

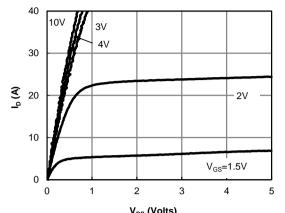
D. The R_{NJA} is the sum of the thermal impedance from junction to lead R_{NJL} and lead to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in² FR-4 board with

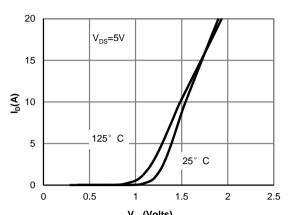
²oz. Copper, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.



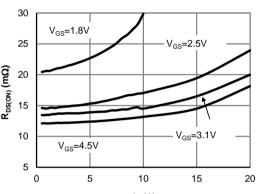
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



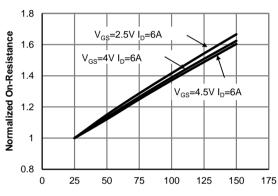
V_{DS} (Volts) Fig 1: On-Region Characteristics (Note E)



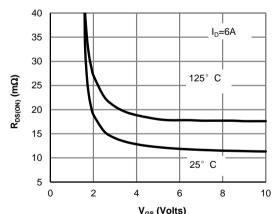
V_{GS}(Volts)
Figure 2: Transfer Characteristics (Note E)



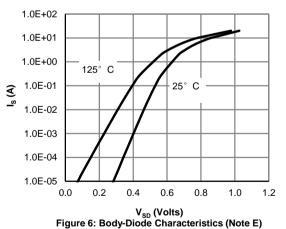
 $\mbox{I}_{\mbox{\tiny D}}$ (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C) Figure 4: On-Resistance vs. Junction Temperature (Note E)



V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)





TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

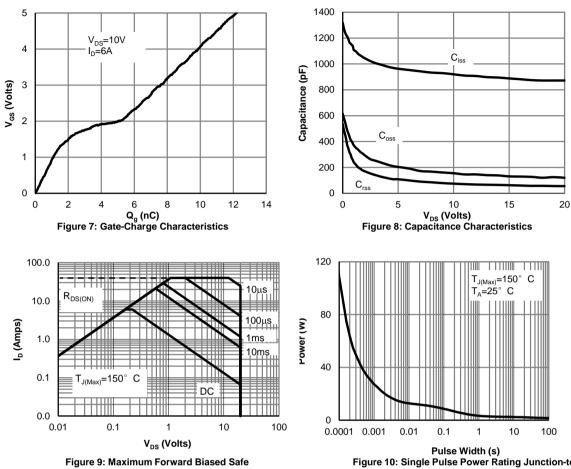
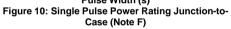
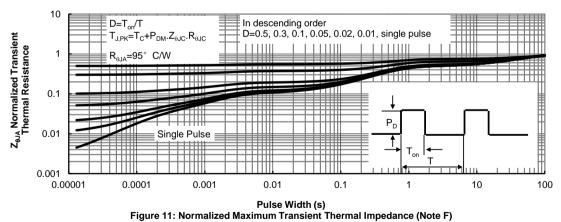


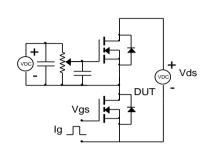
Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

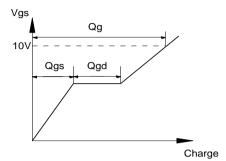




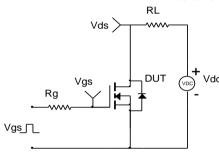


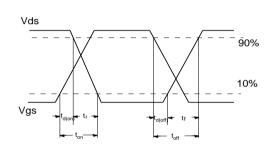
Gate Charge Test Circuit & Waveform



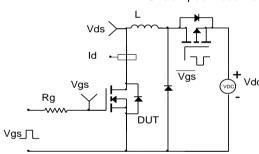


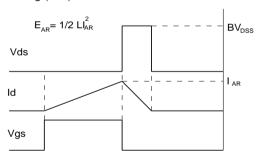
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

